Search	Notes



Application/Control No.	Applicant(s)/Patent under Reexamination
09/528,678	CHAN ET AL.
Examiner	Art Unit

Curtis B. Odom

2611

SEARCHED				
Class	Subclass	Date	Examiner	
375	229-236, 340	7/6/2007	СВО	
		<u> </u>		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
375	229-236	7/7/2007	СВО		
375	346	7/7/2007	СВО		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST: USPAT; USPGPUB; EPO; JPO; DERWENT	7/6/2007	СВО	
INTERFERENCE SEARCH	7/7/2007		